



Form PTO 1449 U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER	SERIAL NUMBER
	NITT.0027	09/931,937
	APPLICANT	
	KAMINAGA et al.	
	FILING DATE	GROUP
	August 20, 2001	2132

U.S. Patent Documents

Examiner Initial	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
MD	6,049,613	04/11/00	Jakobsson			01/13/98
MD	5,631,960	05/20/97	Likens et al			08/31/95

Foreign Patent Documents

Examiner Initial	DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	No
MD	WO 99/67919	06/03/99	PCT			X	

Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

MD	Ramesh Karri, Kaijie Wu, Piyush Mishra, Yongkook Kim, "Concurrent Error Detection of Fault-Based Side-Channel Cryptanalysis of 128-Bit Symmetric Block Ciphers", Proceedings of the 38 th Annual Design Automation Conference, June 18-22, 2001, Proceedings of the Design Automation Conference, New York, pp. 579-584
MD	Dan Boneh, Richard A. DeMillo, Richard J. Lipton, "On the Importance of Checking Cryptographic Protocols for Faults", Advances in Cryptology - Eurocrypt '97, International Conference on the Theory and Application of Cryptographic Techniques Proceedings, 1997, pp. 37-51
MD	European Search Report dated June 30, 2003.

EXAMINER <i>Miss. Sub</i>	DATE CONSIDERED <i>11/02/04</i>
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Examiner: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant